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- 3-State Outputs Drive Bus Lines or Buffer Memory Address Registers
- pnp Inputs Reduce dc Loading
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

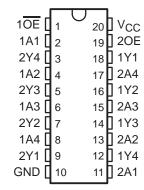
description

These octal buffers/drivers are designed specifically to improve the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. The designer has a choice of selected combinations of inverting and noninverting outputs, symmetrical active-low output-enable (\overline{OE}) inputs, and complementary OE and \overline{OE} inputs. These devices feature high fan-out and improved fan-in.

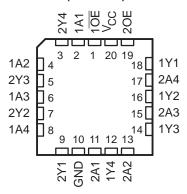
The -1 version of SN74ALS241C is identical to the standard version, except that the recommended maximum I_{OL} of the -1 version is 48 mA. There is no -1 version of the SN54ALS241C.

The SN54ALS241C and SN54AS241A are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS241C and SN74AS241A are characterized for operation from 0°C to 70°C.

SN54ALS241C, SN54AS241A . . . J PACKAGE SN74ALS241C, SN74AS241A . . . DW OR N PACKAGE (TOP VIEW)



SN54ALS241C, SN54AS241A . . . FK PACKAGE (TOP VIEW)



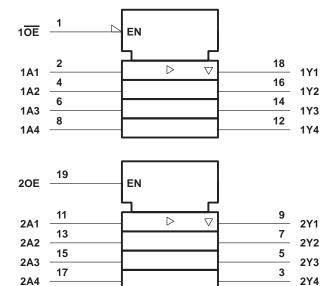
FUNCTION TABLES

INPU	JTS	OUTPUT
10E	1A	1Y
L	Н	Н
L	L	L
Н	Χ	Z

INP	JTS	OUTPUT
20E	2A	2Y
Н	Н	Н
Н	L	L
L	Χ	Z

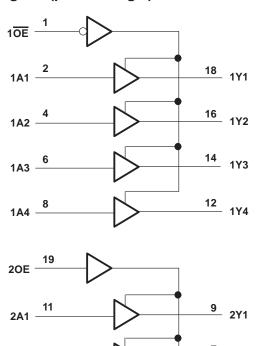
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logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



2Y3

3 2Y4

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V _{CC}	7 V
Input voltage, V _I	7 V
Voltage applied to a disabled 3-state output	5.5 V
Operating free-air temperature range, T _A : SN54ALS241C	−55°C to 125°C
SN74ALS241C	0°C to 70°C
Storage temperature range	-65°C to 150°C

2A2

2A3

2A4 -



^{\$} Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

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recommended operating conditions

		SN54ALS241C SN74ALS241C		UNIT				
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.7			0.8	V
IOH	High-level output current			-12			-15	mA
lai	Low lovel output current			12			24	mA
lOL	Low-level output current						48†	IIIA
TA	Operating free-air temperature	-55		125	0		70	°C

[†] Applies only to the -1 version and only if V_{CC} is between 4.75 V and 5.25 V

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST	CONDITIONS	SNS	4ALS24	1C	SN7	'4ALS24	1C	UNIT
PARAMETER	IEST	CONDITIONS	MIN	TYP‡	MAX	MIN	TYP‡	0.4 0.5 0.0 0.1 20 -0.1 -112 18 26	UNII
VIK	$V_{CC} = 4.5 V,$	$I_{I} = -18 \text{ mA}$			-1.2			-1.2	V
	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2	2		V _{CC} -2	2		1
Vou		$I_{OH} = -3 \text{ mA}$	2.4	3.2		2.4	3.2		V
VOH	$V_{CC} = 4.5 V$	$I_{OH} = -12 \text{ mA}$	2						V
		$I_{OH} = -15 \text{ mA}$				2			
		I _{OL} = 12 mA		0.25	0.4		0.25	0.4	
V_{OL}	V _{CC} = 4.5 V	$I_{OL} = 24 \text{ mA}$					0.35	0.5	V
		I _{OL} = 48 mA (-1 version)					0.35	0.5	
lozh	$V_{CC} = 5.5 V,$	$V_0 = 2.7 \text{ V}$			20			20	μΑ
lozL	$V_{CC} = 5.5 V,$	$V_0 = 0.4 \text{ V}$			-20			-20	μΑ
lį	$V_{CC} = 5.5 V,$	V _I = 7 V			0.1			0.1	mA
lіН	$V_{CC} = 5.5 V,$	V _I = 2.7 V			20			20	μΑ
I _{IL}	$V_{CC} = 5.5 V,$	V _I = 0.4 V			-0.1			-0.1	mA
ΙΟ§	$V_{CC} = 5.5 V,$	V _O = 2.25 V	-20		-112	-30		-112	mA
		Outputs high		9	17		9	18	
ICC	V _{CC} = 5.5 V	Outputs low		15	28		15	26	mA
		Outputs disabled		17	32		17	30	

[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

[§] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

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switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	C _l R1 R2	_ = 50 pl l = 500 Ω 2 = 500 Ω	2, 2, to MAX [†]		UNIT
			SN54AL	S241C	SN74AL	S241C	
			MIN	MAX	MIN	MAX	
t _{PLH}	А	V	3	31	2	11	ns
^t PHL	A	Y	1	17	3	10	115
^t PZH	1 0E	· ·	3	33	3	21	ns
t _{PZL}	10E	Y	3	27	4	21	110
^t PHZ	405	, , , , , , , , , , , , , , , , , , ,	2	17	1	10	
^t PLZ	1 <mark>0E</mark>	Y	2	32	2	15	ns
^t PZH	205		3	38	4	21	
t _{PZL}	20E	Υ	3	30	5	21	ns
^t PHZ	20E	V	2	17	2	10	nc
^t PLZ	ZUE	Y	3	35	3	15	ns

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V _{CC}	
Input voltage, V _I	7 V
Voltage applied to a disabled 3-state output	5.5 V
Operating free-air temperature range, T _A : SN54AS241A	-55°C to 125°C
SN74AS241A	0°C to 70°C
Storage temperature range	−65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		SN	54AS24	1A	SN74AS241A		UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNII
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.8			0.8	V
ІОН	High-level output current			-12			-15	mA
loL	Low-level output current			48			64	mA
TA	Operating free-air temperature	-55		125	0		70	°C

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CO	ONDITIONS	SN54AS241A			SN74AS241A			UNIT
PARAMETER	IESI CC	CNOTTIONS	MIN		MAX	MIN	TYP†	MAX	UNII
VIK	V _{CC} = 4.5 V,	$I_{I} = -18 \text{ mA}$			-1.2			-1.2	V
	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$	V _{CC} -2	2		V _{CC} -2			
Val		$I_{OH} = -3 \text{ mA}$	2.4	3.4		2.4	3.4		V
VOH	V _{CC} = 4.5 V	$I_{OH} = -12 \text{ mA}$	2.4						V
		$I_{OH} = -15 \text{ mA}$				2.4			
V	V 45V	I _{OL} = 48 mA		0.27	0.55				V
VOL	V _{CC} = 4.5 V	I _{OL} = 64 mA					0.31	0.55	
lozh	V _{CC} = 5.5 V,	V _O = 2.7 V			50			50	μΑ
lozL	V _{CC} = 5.5 V,	V _O = 0.4 V			-50			-50	μΑ
lį	V _{CC} = 5.5 V,	V _I = 7 V			0.1			0.1	mA
lіН	$V_{CC} = 5.5 V$,	V _I = 2.7 V			20			20	μΑ
I _{IL}	V _{CC} = 5.5 V,	V _I = 0.4 V			-1			-1	mA
1 ₀ ‡	V _{CC} = 5.5 V,	V _O = 2.25 V	-50		-150	-50		-150	mA
		Outputs high		22	35		22	35	mA
Icc	V _{CC} = 5.5 V	Outputs low		61	90		61	90	
	Outputs disabled	Outputs disabled		35	56		35	56	

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)		CL = 50 R1 = 500 R2 = 500 A = MIN	Ω , Ω , to MAX	§	UNIT
			SN54A	S241A	SN74A	S241A	
			MIN	MAX	MIN	MAX	
^t PLH	А	Y	2	9	2	6.2	ns
^t PHL	A		1	7	1	6.2	115
^t PZH		Υ	1	10	1	9	ns
tPZL	1 OE	JE Y	2	8	2	7.5	115
^t PHZ	405	V	1	6.5	1	6	ns
^t PLZ	1 OE	Y	1	10.5	1	9	115
^t PZH	205		2	11	2	10.5	
t _{PZL}	20E	Υ	3	9.5	3	8.5	ns
^t PHZ	20E	Υ	1	7	1	7	
t _{PLZ}	ZUE	ſ	2	12	2	12	ns

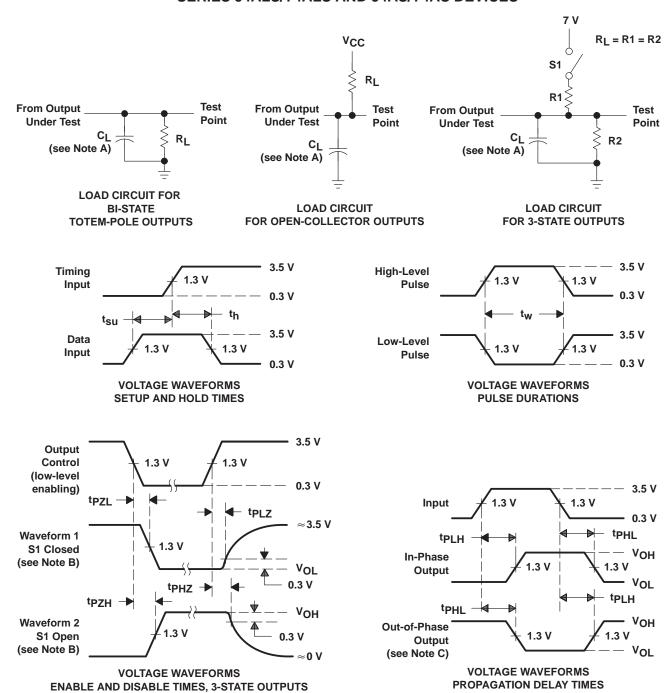
[§] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, los.

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PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



- NOTES: A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
 - D. All input pulses have the following characteristics: PRR \leq 1 MHz, $t_f = t_f = 2$ ns, duty cycle = 50%.
 - E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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